

Article

ZnS/SiO₂ Passivation Layer for High-Performance of TiO₂/CuInS₂ Quantum Dot Sensitized Solar Cells

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Abstract: Suppressing the charge recombination at the interface of photoanode/electrolyte is the crucial way to improve the quantum dot sensitized solar cells (QDSSCs) performance. In this scenario, ZnS/SiO₂ blocking layer was deposited on TiO₂/CuInS₂ QDs to inhibit the charge recombination at photoanode/electrolyte interface. As a result, the TiO₂/CuInS₂/ZnS/SiO₂ based QDSSCs delivers a power conversion efficiency (η) value of 4.63%, which is much higher than the TiO₂/CuInS₂ (2.15%) and TiO₂/CuInS₂/ZnS (3.23%) based QDSSCs. Impedance spectroscopy and open circuit voltage decay analyses indicate that ZnS/SiO₂ passivation layer on TiO₂/CuInS₂ suppress the charge recombination at the interface of photoanode/electrolyte and enhance the electron lifetime.

Keywords: QDSSCs; Charge recombination; ZnS/SiO₂; Passivation layer

1. Introduction

Semiconductor quantum dots (QDs) based on II–VI group such as CdSe [1], CdTe [2], CdS [3], PbS [4], PbSe [5], and etc. have been extensively studied for QD sensitized solar cell (QDSSC) and photocatalysis applications, due to tunable band gap, hot electron injection, higher absorption coefficients, and multiple excitation generation (MEG) [6,7]. However, highly toxic Cd or Pb-containing QDs based solar cells show the excellent photostability and high power conversion efficiencies (PCEs). However, high toxicity of Cd or Pb still limit the commercial applications in consideration of environmental and health concerns. Therefore, the development of “green” QDs without carcinogenic heavy metal element is crucial for the practical utilizations of QDSSCs.

Less-toxic I–III–VI₂ group QDs, specifically CuInS₂ (CIS) QD has been attracted as “green” QDs due to high absorption coefficient ($\sim 10^5 \text{ cm}^{-1}$) and optimal band gap energy (1.0–1.5 eV), both of which make it a promising candidate as a sensitizer in QDSSCs [8–10]. There are two common approaches have been demonstrated for assembling CuInS₂ QDs onto TiO₂ electrodes: by direct adsorption or bifunctional-linker-assisted adsorption and by successive ionic layer adsorption [11,12]. Owing to its facile and reproducible preparation, the SILAR process gained much attention for depositing QDs onto TiO₂ surface with high QD loading and well controllable in size of QDs [13,14].

Chang et al. developed the TiO₂/Cu₂S/CuInS₂/ZnS photoanode using the SILAR process and achieved a PCE of 2.52% [15]. Zhou et al. prepared QDSSCs based on CuInS₂ and introduction of In₂S₃ buffer layer using SILAR process, which presented as high as $\sim 1.06\%$ PCEs [16]. Meng et al. developed a CuInS₂ QDs on reduced graphene oxide sheets using facile one-pot solvothermal approach and

delivered a PCE of 1.5% [17]. Han et al. fabricated $\text{PbS}/\text{CuInS}_2/\text{TiO}_2$ using SILAR process and obtained a PCE of 4.11% [18]. However, the lower performance of QDSSC is due to severe charge recombination process at the $\text{TiO}_2/\text{QD}/\text{electrolyte}$ interface. To reduce the charge recombination in QDSSCs, thin wide band gap inorganic barrier layer was deposited over TiO_2 electrode, which acts as an energy barrier hindering electrons from recombining. Until now, ZnS is a promising passivation layer for suppressing the interfacial recombination in QDSSCs [19]. The ZnS over layer is introduced by the facile SILAR process, which covers the TiO_2 layer and the surface of QDs toward the electrolyte. Therefore, the deposition of ZnS layer is useful technique to improve the solar cells performance due to the passivation of the QD surface states, yielding in suppression of the recombination processes [20].

Herein, ZnS/ SiO_2 double barrier coating was sequentially deposited on CuInS_2 QD to suppress the recombination in QDSSCs. $\text{TiO}_2/\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ structure favors the improvement of photovoltaic properties of the QDSSCs. The QDSSC based on the CuInS_2 QD sensitizer and ZnS/ SiO_2 double layer exhibits a PCE of 4.63% (with short circuit current density (J_{SC}) = 12.83 mA cm^{-2} , an open circuit voltage (V_{OC}) = 0.603 V, fill factor (FF) = 0.598) under AM 1.5 G one full sun illumination, which is much higher than the $\text{CuInS}_2/\text{ZnS}$ (PCE = 3.23%) and CuInS_2 (PCE = 2.15%).

2. Results and Discussion

2.1. Morphological Characterization

Figure 1(a,a1,b,b1,c,c1) show the scanning electron microscopy (SEM) images of the CuInS_2 , $\text{CuInS}_2/\text{ZnS}$, and $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ layers on the surface of TiO_2 . The bare CuInS_2 film in Figure 1a,a1 exhibit uniformly distributed nanoparticles on the TiO_2 surface. All the samples exhibit the almost similar surface morphology and there is a slight increase in the particle size of with the deposition of ZnS and ZnS/ SiO_2 layers; however, the specific change in size of particles is difficult to examine and was inconclusive. Therefore, elemental mapping from SEM analysis and X-ray photoelectron spectroscopy (XPS) measurements were conducted to identify the ZnS and ZnS/ SiO_2 coatings on the surface of TiO_2 . Moreover, the compositional distributions of a $\text{TiO}_2/\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ sample are further demonstrated by elemental mapping behavior, in which the homogeneous distribution and coexistence of Cu, In, Zn, S, Si and O elements are clearly observed in $\text{TiO}_2/\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ sample (Figure 2). Such elemental mapping results unambiguously indicate that the CuInS_2 , ZnS and SiO_2 were deposited successfully on the TiO_2 surface.

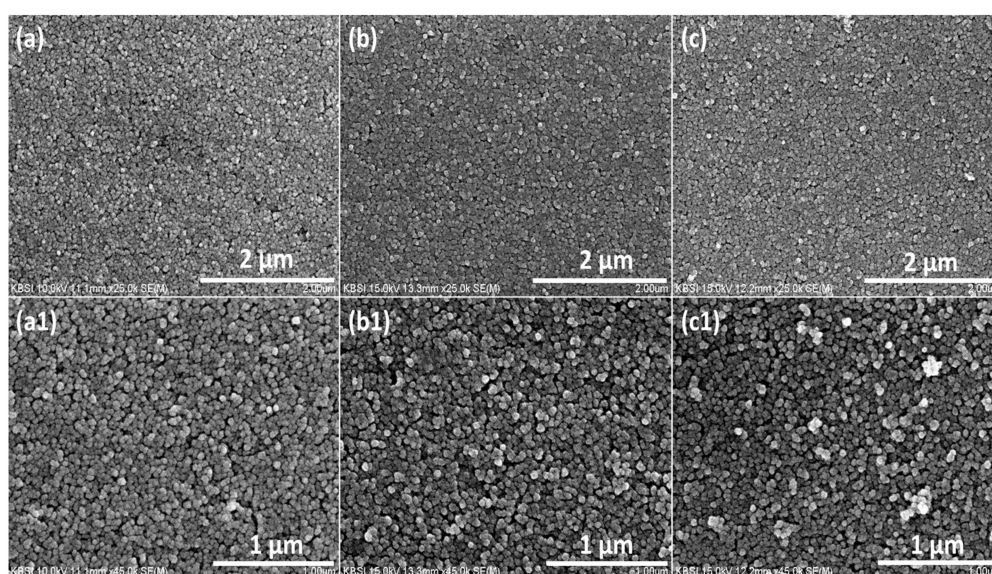


Figure 1. SEM images of the (a,a1) CuInS_2 , (b,b1) $\text{CuInS}_2/\text{ZnS}$, and (c,c1) $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ layers on the surface of TiO_2 .

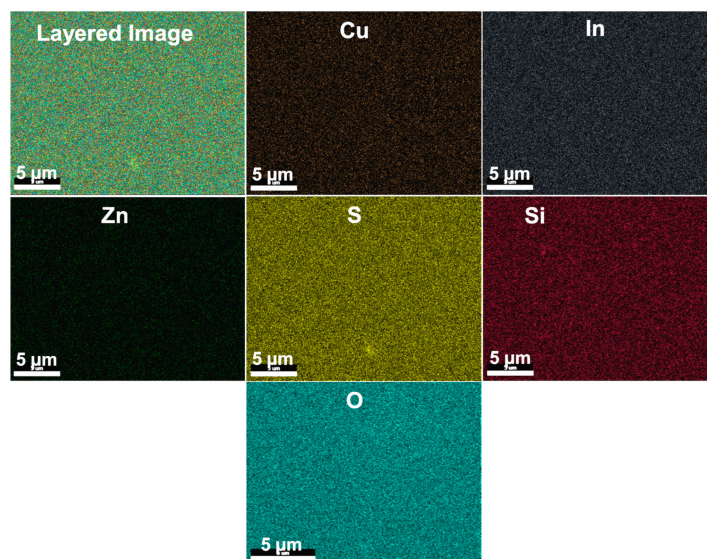


Figure 2. Elemental mapping images of the Cu, In, Zn, S, Si and O for the $\text{TiO}_2/\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ samples.

The composition of the $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ sample was investigated by XPS, as depicted in Figure 3. The XPS survey spectra in Figure 3a depict peaks for Ti_{2p} , O_{1s} , C_{1s} , Cu_{2p} , In_{3d} , Zn_{2p} , S_{2p} , and Si_{2p} , respectively. The binding energy of $\text{Cu } 2p_{3/2}$ and $\text{Cu } 2p_{1/2}$ were observed at 932.9 and 952.7 eV, respectively (Figure 3b), with no evident shake-up satellite signals in this $\text{Cu}2p$ spectrum. The two major peaks of In are observed at 445.4 eV and 452.9 eV for $\text{In } 3d_{5/2}$ and $\text{In } 3d_{3/2}$, respectively (Figure 3c). Figure 3d depicts the binding energies for $\text{Zn } 2p_{3/2}$ and $\text{Zn } 2p_{1/2}$ of the prepared sample of $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ at 1023.2 eV and 1046.2 eV respectively. The S 2p spectrum was yielded peaks of $\text{S } 2p_{3/2}$ and $\text{S } 2p_{1/2}$ at 162.0 eV and 163.0 eV binding energies, respectively (Figure 3e). In the Si 2p spectrum (Figure 3f), the main peak observed at 103.2 eV has been ascribed to Si in the oxidized form (SiO_2) and the other shoulder peak can be assigned to the presence of crystalline Si (elemental Si).

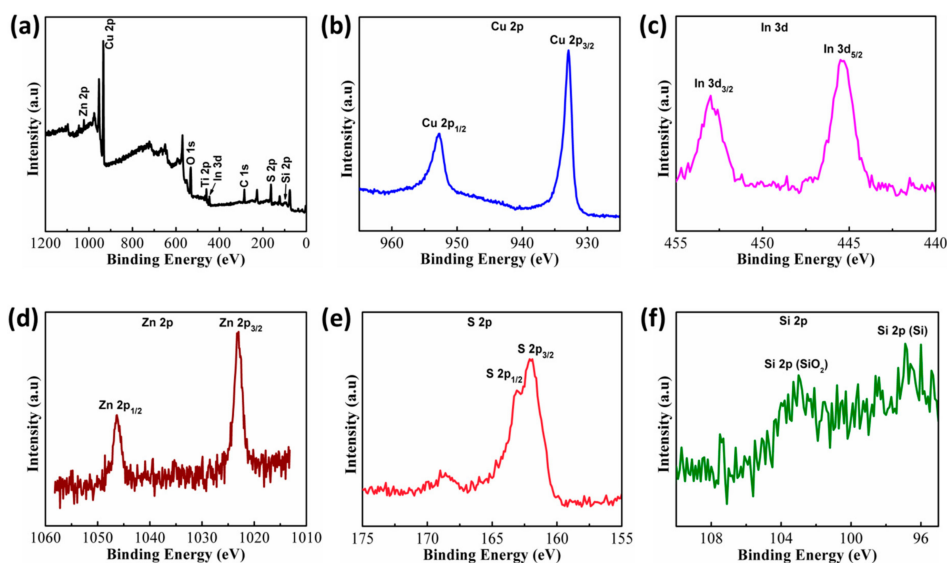


Figure 3. (a) XPS survey of $\text{TiO}_2/\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ film. Core-level XPS spectrum of (b) Cu 2p, (c) In 3d, (d) Zn 2p, (e) S 2p, and (f) Si 2p elements.

2.2. Electrochemical Characterization

The J-V curves of the QDSSCs based on various photoanodes were obtained under AM 1.5 illumination (100 mW cm^{-2}) are displayed in Figure 4 and the corresponding photovoltaic parameters are tabulated in Table 1. When only CuInS_2 are deposited on TiO_2 film, the QDSSC exhibits a J_{SC} of 7.87 mA cm^{-2} , V_{OC} of 0.509 V, FF of 0.537, resulting a low PCE of 2.15%. However, when ZnS and ZnS/ SiO_2 passivation layers were deposited, all the photovoltaic parameters were greatly improved; the QDSSCs with a ZnS/ SiO_2 layer exhibit the good performance, with J_{SC} , V_{OC} , and FF reaching 12.83 mA cm^{-2} , 0.603 V, and 0.598, respectively and the highest PCE of 4.63%, which is much higher than the PCE of 3.23% with a ZnS passivation layer. It is observed that the ZnO/ SiO_2 layer exhibiting higher performance than the bare and ZnS layers in QDSSCs, which is due to suppression of recombination losses in QDSSCs and increases the charge collection efficiency.

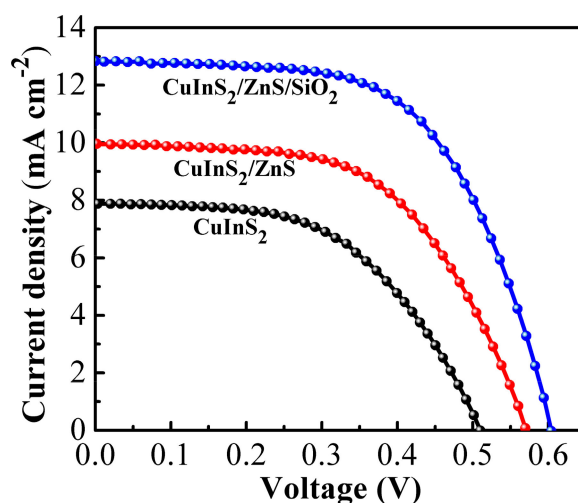


Figure 4. Current density–voltage (J–V) curves of CuInS_2 , $\text{CuInS}_2/\text{ZnS}$ and $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ based QDSSCs.

Table 1. Photovoltaic properties and EIS results of QDSSCs fabricated various sensitized conditions.

Cell	V_{oc} (V)	J_{sc} (mA cm^{-2})	FF	$\eta\%$	R_s (Ω)	R_{CE} (Ω)	R_{ct} (Ω)
CuInS_2	0.509	7.87	0.537	2.15	9.34	0.84	30.65
$\text{CuInS}_2/\text{ZnS}$	0.569	9.95	0.571	3.23	10.03	1.03	23.95
$\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$	0.603	12.83	0.598	4.63	10.24	1.16	55.02

Electrochemical impedance spectroscopy (EIS) characterizations were conducted to identify the charge recombination processes in devices under forward bias (V_{OC}) and dark condition. Figure 5 depicts the EIS spectra of various photoelectrodes and the Nyquist plots were fitted using Z-view software with the equivalent circuit provided in the inset of Figure 5. The corresponding fitting results are shown in Table 1. The Nyquist plot consists of two semicircles and the first semicircle represents the resistance (R_{CE}) at the CE/electrolyte interface. The second semicircle denotes the charge transfer resistance (R_{ct}) at the interface of the $\text{TiO}_2/\text{QDs}/\text{electrolyte}$. At higher frequency, the intercept on the real axis corresponds to the series resistance (R_s) of FTO substrate and the resistance of FTO/ TiO_2 [21,22]. It is noticed that there are no apparent differences observed in the R_s and R_{CE} due to the same CE and electrolyte used in these experiments. However, there is a noticeable difference in R_{ct} ; the R_{ct} value for the $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ based QDSSCs is 55.02Ω , while R_{ct} value for the $\text{CuInS}_2/\text{ZnS}$ and CuInS_2 based QDSSCs are only 30.65Ω and 23.95Ω , respectively. The charge recombination resistance at the $\text{TiO}_2/\text{QDs}/\text{electrolyte}$ interface is mainly observed by R_{ct} . The higher R_{ct} value represents the suppressed recombination of the electrons and holes, and enhances the

electron transfer process at the interface of $\text{TiO}_2/\text{QDs}/\text{electrolyte}$. Therefore, it is confirmed that the deposition of ZnS/SiO_2 layer on the CuInS_2 QDs favors the efficient electron transfer from CuInS_2 to TiO_2 photoanodes with suppression of the interfacial charge recombination processes, which is more effectively than that of the ZnS passivation layer.

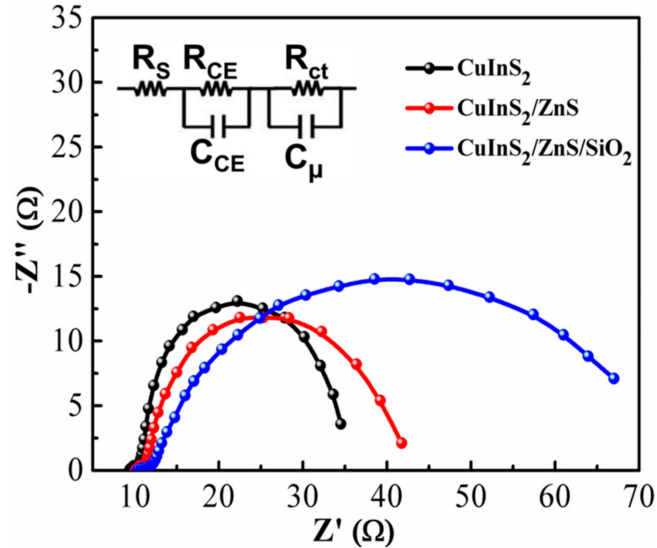


Figure 5. EIS curves of QDSSCs based CuInS_2 and $\text{CuInS}_2/\text{ZnS}$ and $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ cells in the form of Nyquist-plots and the inset shows the equivalent circuit used to fit the impedance spectra.

Furthermore, Open circuit voltage decay (OCVD) measurements were carried out to study the charge recombination process in QDSSCs and the results. OCVD analysis of QDSSCs was performed during relaxation from an illuminated quasiequilibrium state to the darkness. Figure 6 depicts the OCVD plots of the QDSSCs based on CuInS_2 , $\text{CuInS}_2/\text{ZnS}$ and $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ photoanodes. Apparently, the $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ cell delivered considerably longer decay times than the CuInS_2 and $\text{CuInS}_2/\text{ZnS}$ cells, indicating a suppression of charge recombination process. Moreover, the V_{OC} decay and electron life time are directly related according to following equation [23]:

$$\tau_e = -\left(\frac{k_B T}{e}\right) \left(\frac{dV_{\text{OC}}}{dt}\right)^{-1} \quad (1)$$

where k_B is the Boltzmann constant, T is the absolute temperature, and e is the electronic charge. It can be noticed that the τ_e of all the devices increases with decreasing V_{OC} . Among the QDSSCs investigated, the $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ delivers longer τ_e than the $\text{CuInS}_2/\text{ZnS}$ and CuInS_2 devices, implying suppressed recombination and efficient electron transfer at the $\text{TiO}_2/\text{QDs}/\text{electrolyte}$, which is consistent with EIS analysis. Therefore, the slower V_{OC} decay and longer τ_e of the $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ device efficiently suppressed the electron recombination from TiO_2 and QDs to electrolyte and higher charge collection efficiency contribute to the increased photovoltaic performance.

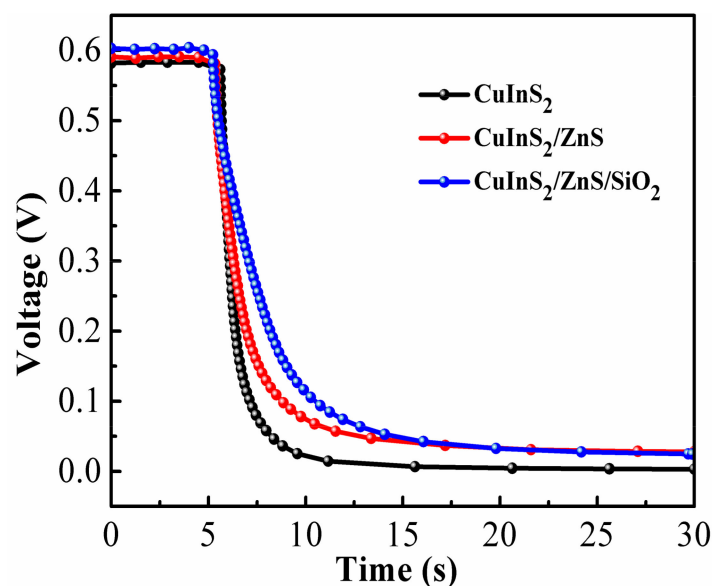


Figure 6. OCVD curves of QDSSCs based CuInS_2 and $\text{CuInS}_2/\text{ZnS}$ and $\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ cells.

Several paths for charge recombination occur at the $\text{TiO}_2/\text{QDs}/\text{electrolyte}$ interface, which suppress the performance of QDSSCs. The deposition of ZnS/SiO_2 layer on the surface of $\text{TiO}_2/\text{CuInS}_2$ can effectively suppress the charge recombination process at the photoanode/electrolyte interface (Figure 7) and enhance the QDSSCs performance.

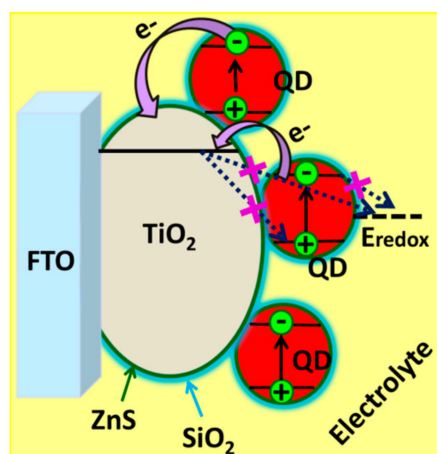


Figure 7. Possible charge transfer behavior in the $\text{TiO}_2/\text{CuInS}_2/\text{ZnS}/\text{SiO}_2$ QDSSCs.

3. Materials and Methods

3.1. Preparation of TiO_2 Electrodes

TiO_2 paste (20 nm, Ti-Nanoxide HT/TP, Solaronix) was doctor bladed on fluorine-doped tin oxide (FTO, $1.3 \times 1.6 \text{ cm}^2$) substrate and heated at 450°C for 30 min. The film thickness was about $7.5 \mu\text{m}$ with an active area of 0.25 cm^2 [24].

3.2. Deposition of CuInS_2 QDs on TiO_2 Electrodes

CuInS_2 QDs were deposited on the TiO_2 substrate using the SILAR process. TiO_2 electrodes were immersed into the three different solutions: one of 0.05 M of $\text{Cu}(\text{NO}_3)_2$ for 2 min, another of 0.05 M of $\text{In}(\text{NO}_3)_3$ for 2 min, and a final one of 0.1 M of Na_2S for 5 min. Following each immersion, the samples

were rinsed with deionized (DI) water for 1 min to remove the excess precursors. This procedure comprises one CuInS₂ SILAR cycle and was repeated six times.

3.3. Deposition of ZnS, ZnS/SiO₂ Passivation Layers on TiO₂/CuInS₂ Electrodes

The ZnS passivation layer was deposited on TiO₂/CuInS₂ electrodes by a SILAR process. Typically, TiO₂/CuInS₂ electrodes were successively immersed into aqueous solutions containing 0.1 M of Zn(NO₃)₂ and 0.1 M Na₂S for 1 min, respectively. This process was repeated for three times and the electrode is named as CuInS₂/ZnS. Furthermore, SiO₂ coating was deposited by dipping the CuInS₂/ZnS electrodes in ethanol solution containing 0.01 M tetraethylorthosilicate and 0.1 M NH₄OH for 1 h. The as-fabricated electrode is termed as CuInS₂/ZnS/SiO₂.

3.4. QDSSC Fabrication

CuS CE on FTO substrate was fabricated according to the literature [25]. The photoanode and CuS CEs were combined using sealant (SX 1170-60, Solaronix) and the space between the electrodes was filled with polysulfide electrolyte (1 M Na₂S, 2 M S, and 0.2 M KCl in methanol and water at a ratio of 7:3).

3.5. Characterizations

The morphology of the samples were evaluated by SEM (S-2400, Hitachi). XPS measurement was investigated using VG Scientific ESCALAB 250. The J-V measurements were examined under AM 1.5 sunlight (100 mW cm^{−2}) using an ABET Technologies (USA) solar simulator. EIS was investigated using a BioLogic SP-150 work station under one sun illumination over the frequency of 100 mHz–500 kHz.

4. Conclusions

Introduction of ZnS/SiO₂ passivation layer on TiO₂/CuInS₂ QDs has been demonstrated to be an effective and promising approach to significantly suppress the charge recombination at the interface of photoanode/electrolyte and enhance the power conversion efficiency. Interestingly, an overall η of 4.63% was obtained for the TiO₂/CuInS₂/ZnS/SiO₂ device, which is 43% enhancement over the η = 3.23% for the TiO₂/CuInS₂/ZnS and more than 115% increment over the η = 2.15% for the TiO₂/CuInS₂ device. Overall, ZnS/SiO₂ passivation layer is an effective approach to enhance the overall power conversion efficiency of QDSSCs.

Author Contributions: H.J.K. and J.H.B performed device performance measurements. H.S. and M.S. helped in the analysis of the data. C.V.V.M.G. designed this research idea and writing the manuscript.

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Conflicts of Interest: The authors declare no conflict of interest.

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